

Quantum and CryoCMOS: Enabling the Future of Computing with Advanced Test & Measurement Tools

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Outline

IQ3000 Cryogenic Wafer Prober

- Random Telegraph Noise on Cryo-CMOS
- Parametric Measurements of Superconducting Circuits (SFQ)

IQ2000 Rapid Chip-Scale Probing

- Photonic Integrated Circuit Probing
- Fiber Alignment Optimization at Cryo

Model 106 ADR Cryostat with PQ500 for QPU Screening

- S-Parameter Measurements
- Dispersive Readout of Quantum Processor



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Cryogenic Wafer-Scale Probing HPD IQ3000



HPD IQ3000

4K Cryogenic Wafer Prober (Wet)

Fully automated cryogenic wafer probing at 4K

Cryogen Control (Wet Only)

- · Warm Water Bath
- Vacuum pump with flow controller and pressure regulator
- Recirculation with Binary Gas Analyzer and a 3-way directional valve

Vision System

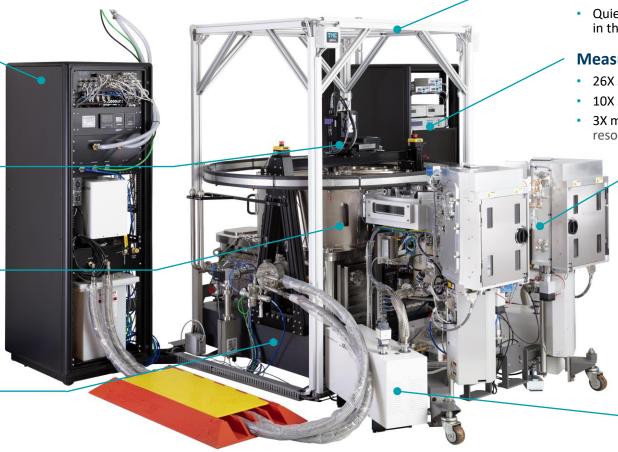
- 50 mm XYZ Travel
- <3 um resolving power
- Pneumatic lift and rotatable beam for easy servicing

Probe Station

- Gas spring assisted vacuum lid and latchable shield lids
- <4.5 K with 44 RF probes in contact
- +/- 112 mm XY, 0 13 mm Z, +/- 10° Theta motion

Rigid Construction

- A solid granite base with a rigid motion structure
- Allows for rapid die to die movement and fast settling times
- Up to 25 mm/s travel speed



Magnetic Cancellation

- Active cancellation with passive cryogenic shielding
- Quiescent magnetic field environment of <200 nT in the 4 K wafer space

Measurement and Control Electronics

- 26X system thermometers
- 10X 50 W heaters for rapid warmup in <8 hrs
- 3X magnetic probes with 0-200 uT range and 1 nT resolution

Wafer Cassette Loader

- Automated loading for 200 mm and 150 mm wafers
- Up to 25 wafer capacity
- <15 minute exchange time between wafers</p>

Vacuum Feedthroughs (Not Shown)

- Two large configurable vacuum flanges with additional smaller ports
- Large ports are 12 in x 18 in and 12 in x 26 in
- Base 56 RF (18 GHz) and 520 DC

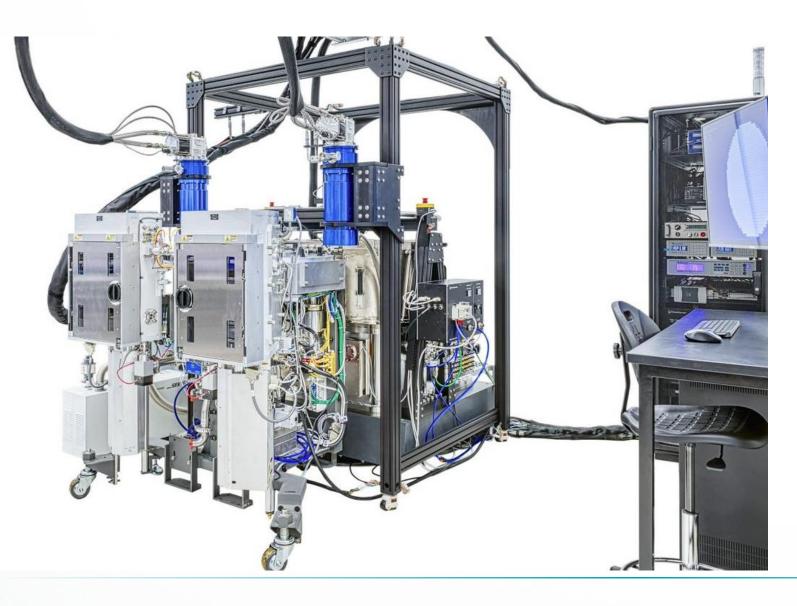
Automated Pumping System

- Load lock isolated pumping systems for wafer loading while system is at base
- Full system pump down in <40 minutes



HPD IQ3000 | 4K Cryogenic Wafer Prober (Dry)

Fully automated cryogenic wafer probing at 4K



- Up to 300mm wafers
- Dry system operation (no liquid cryogen)
- Probe card compatible
- < 15-minute wafer cooldown to 4K





IQ3000 – Cryogenic Wafer Prober Details

Probe card installation



Wafer Exchange Cooldown

(X)

40

40

0:00

0:05

Timestamp

RF Feedthroughs



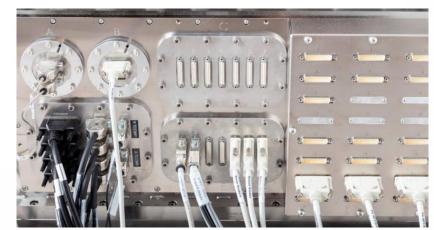
Wafer under probe card fixture



Chuck without wafer



Operational and DC feedthroughs





IQ3000 | SFQ Device Characterization at 4K

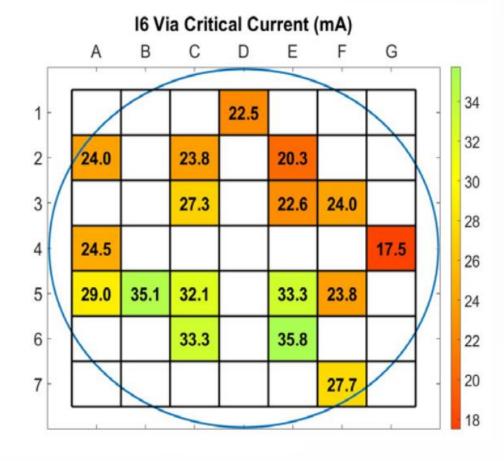
of Devices = 24 SQUID-based Test Circuits

Test Method	Time to Measure at 4K
Conventional singulated die testing (dicing, wire bonding)	> 1 week
IQ3000 4K Cryogenic Wafer Prober with 200mm wafer	5 hours

Characterization Measurements

- 1. SQUIF B field
- 2. Inductance/unit length
- 3. JJ critical current
- 4. Normal resistance
- 5. Gap current (V_g)





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IMS-K-Cryo-LFN Integrated Measurement Solution

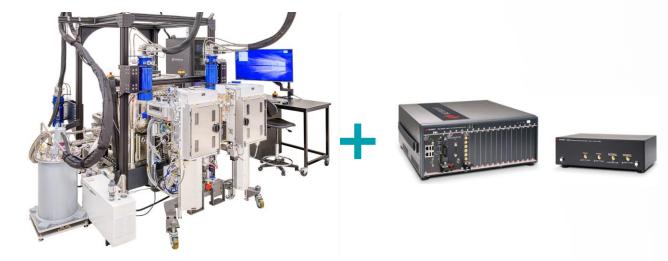




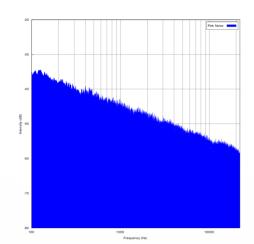


Wafer Service SkyWater Technology ULN Measurement

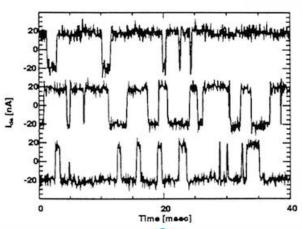
- Measured at 5 temperature points between 4K and 120K
- ULN measurements of 1/f, I/V, and RTS
- Used for testing ROIC in imaging and sensing applications
- IR Sensors, Night Vision, Military Surveillance, Industrial/Automotive imaging



HPD IQ3000



Keysight A-LFNA





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Component Test Service | LNA Characterization

- Establish a standard service
- Cryogenic LNAs used for Quantum Computing
- 4K measurement for noise temperature as low as 1 K (NF 0.01 dB)
- Calibrated S-Parameters
- Cheaper and more reliable components to scale quantum















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Measurement Setup Model 106 Cryostat



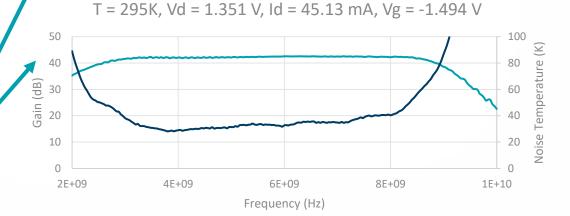


LNF RT SP T = 295K, Vd = 1.351 V, Id = 45.15 mA, Vg = -1.527 V

One Device

11

Two Cooldowns



LNF RT NF



S11 LogM 10dB/0dB

-S21 LogM 10dB/0dB

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New Product Introduction Rapid Chip-Scale Probing HPD Model IQ2000



Photonics Applications in Quantum Computing

Components of a Photonic Quantum Computer

- Single photon source (ex. quantum dots, color centers, squeezed light)
- Single photon detector (ex. SNSPD, TES)
- Photonic circuit elements (waveguides, couplers, phase shifters)

Cryogenic conditions for light source • Coupled to photonic chip with fiber array • Edge (low loss) or vertical/surface coupling (higher loss) • RF/DC lines to control/program the circuit • Need RF wiring to readout detectors

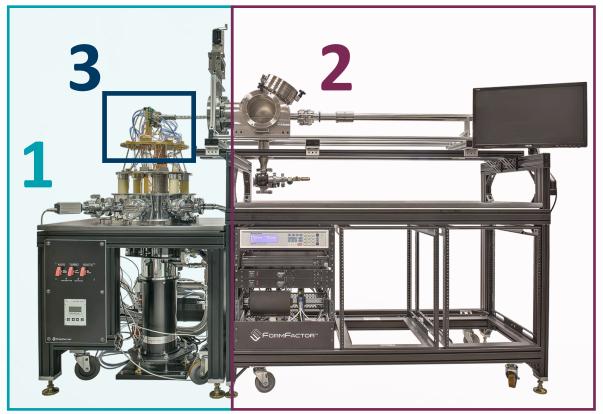


Detector Types

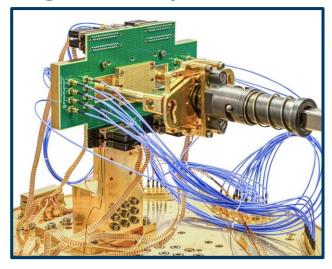
Test and measurement strategies needed for each of the cryogenic elements

IQ2000 | Three Configurations for Your Test Suite

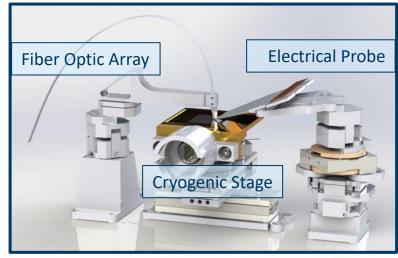
- Base Cryogenic Platform (< 4K or < 2K)
- 2. Rapid Sample Transfer, High Throughput
- 3. Configurable Sample Space
 - a) Photonics
 - b) Electrical high density, high bandwidth
 - c) Electrical Lab R&D



High Density Electronic

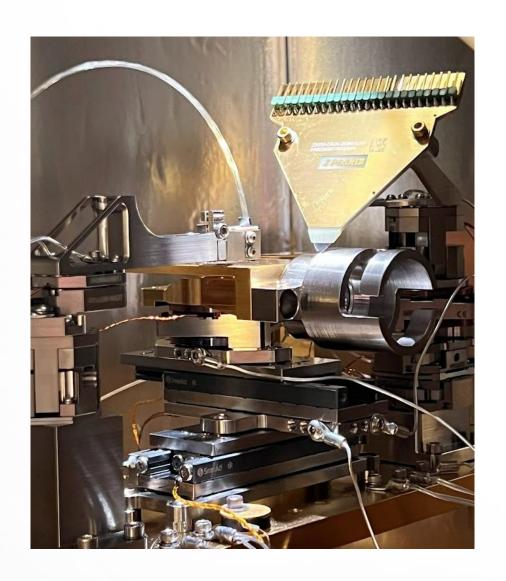


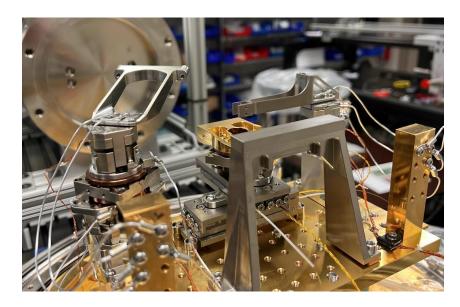
Photonics

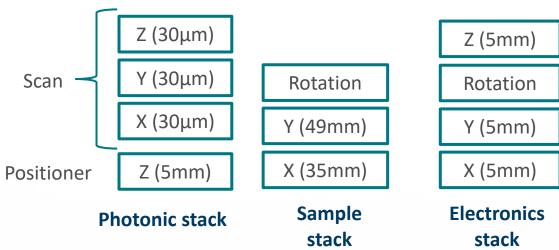




IQ2000 Rapid Chip-Scale Probing | Photonics Experimental Space





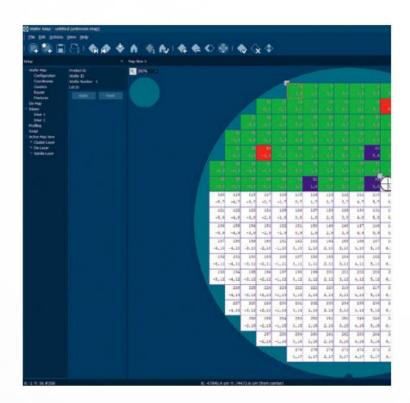


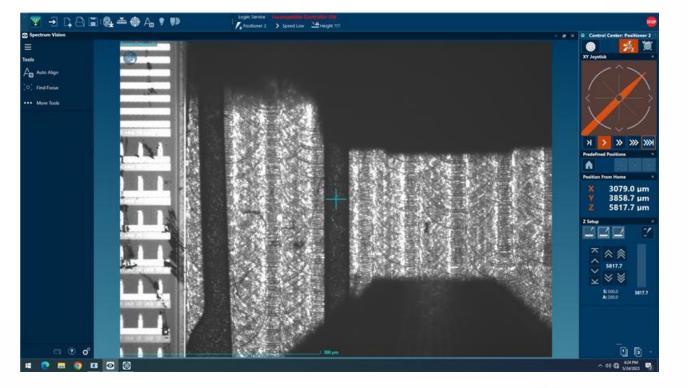


Velox™ Control Software

- FormFactor's software for 200 mm and 300 mm wafer probe stations
- Universal standard for semi- and fully-automated systems
- Multi-die testing with integrated positioner control
- Streamlined communication with test & measurement equipment

Overhead Microscope & Integrated 45-degree mirror enable fiber alignment to surface grating



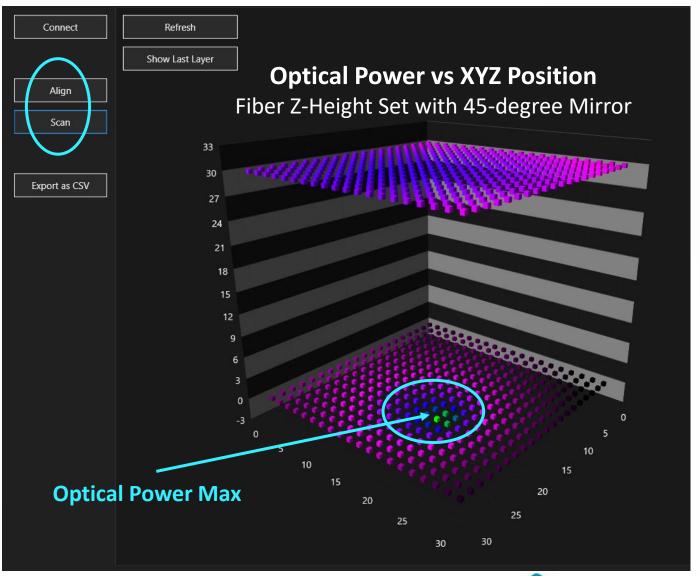




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IQ2000 | Fiber Alignment & Position Optimization

- Auto-align fiber array in XYZ
- Scan range: 30μm x 30μm x 30μm
- FAU with 16 fibers (customizable)
- Loop-back structure to measure optical power





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< 50 mK Test & Measurement HPD ADR Cryostats



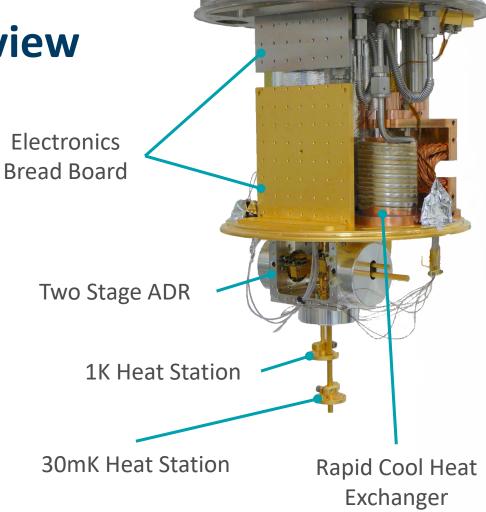




ADR Cryostat Product Line Overview

Research Cryostats

- Model 106 & Model 107 ADR Cryostats
- "Turn-Key" cryogen-free system.
- Low base temperature and fast cycle times:
 - Single-shot, 30 mK Base Temperature.
 - Long, >200 hour, hold time at 100mK under no load.
- Vibration minimizing design.
- Vertical Atlas Stand or flip-able Titan Stand.
- Optional LN₂ rapid cooldown: cooldown to mK in 10-15 hours, model & configuration dependent.



HPD Rainier 103









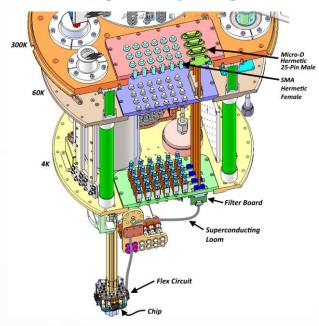
50mK

Tailored Cryostat Solutions

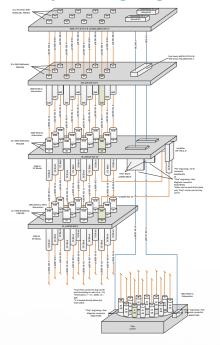
From Concept to Delivery

- Add in-line RF and DC elements
- High density feedthroughs
- Magnetic shielding for sensitive measurements
- Cooldown to 50mK in under 16 hours

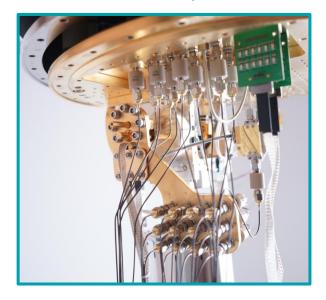
High density wiring



Example wiring diagram



Custom thermal intercept circuit elements



Bulkhead feedthrough



Magnetic shielding around sample





4K

300mK

Superconducting QC | Chip-Scale Solution

50mK



No wire bonding

No packaging

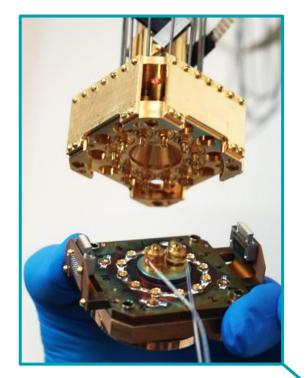
< 16 hour cooldown

Find High Performing
Devices Fast



2X Rapid Deployment

PQ500 Probe Socket



Model 106 ADR Cryostat



Example Measurements in milli-Kelvin Test System

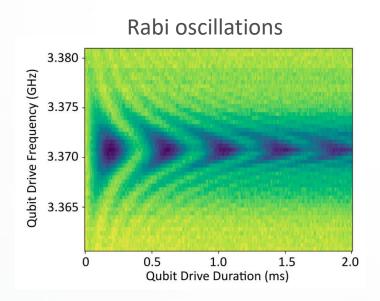
Qubit & Resonator Pre-characterization at 50mK

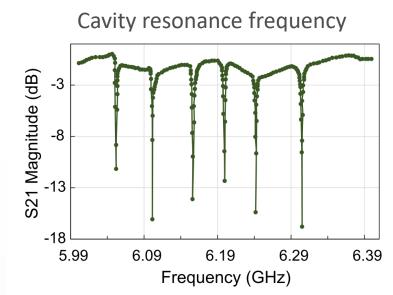
- Cavity resonance frequency
- Cavity dispersive shift
- Qubit transition frequency
- Rabi oscillations
- Qubit relaxation time (T₁)

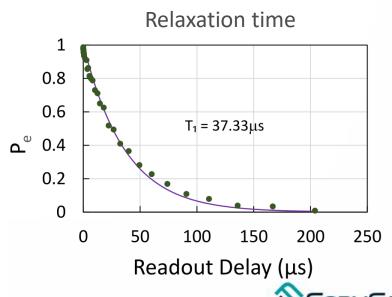


Data courtesy of SeeQC*

Reduce QPU Bring-Up by Days

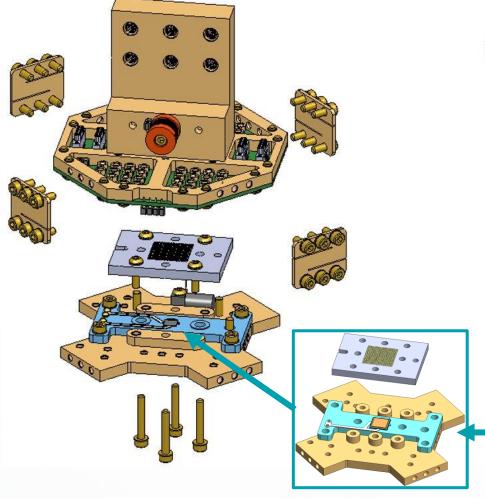




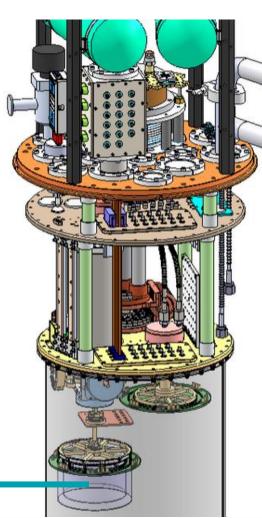


Probe Socket PQ500 Designs for Different Cryostat

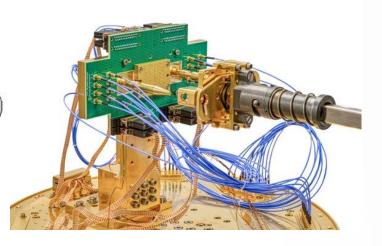
PQ500 Probe Socket with Active Alignment



PQ500 in Cryostat



PQ500 for the IQ2000









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